

## STD10P6F6-VB Datasheet

## P-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ)		
- 60	0.061 at V <sub>GS</sub> = - 10 V	- 30	10		
- 00	0.072 at $V_{GS}$ = - 4.5 V	- 25	10		

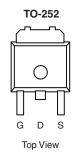
#### **FEATURES**

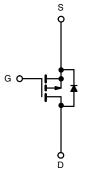
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % UIS Tested

#### APPLICATIONS

· Load Switch







P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T <sub>C</sub> =	25 °C, unless othe	rwise noted			
Parameter	Symbol	Limit	Unit		
Gate-Source Voltage		V <sub>GS</sub>	± 20	V	
Continuous Drain Current ( $T_1 = 175 ^{\circ}$ C)	T <sub>C</sub> = 25 °C	L	- 30		
Continuous Drain Current (1) = 175 C)	T <sub>C</sub> = 100 °C	l <sub>D</sub>	- 25		
Pulsed Drain Current	I <sub>DM</sub>	- 30	А		
Continuing Source Current (Diode Conduction)		۱ <sub>S</sub>	- 20		
Avalanche Current		I <sub>AS</sub>	- 20	1	
Single Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	7.2	mJ	
Maujarum Daura Dissigntion	T <sub>C</sub> = 25 °C	Р	34 <sup>a</sup>	w	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	4 <sup>b</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C	

	Symbol	Typical	Maximum	Unit
$t \le 10$ sec	R <sub>thJA</sub>	20	25	°C/W
Steady State		62	75	
	R <sub>thJC</sub>	5	6	
		$\frac{t \le 10 \text{ sec}}{\text{Steady State}} \qquad $	$\begin{array}{c c} t \leq 10 \text{ sec} & & \\ \hline \\ \hline$	$\begin{array}{c c} t \leq 10 \text{ sec} \\ \hline \text{Steady State} \end{array} \begin{array}{c c} R_{thJA} \end{array} \begin{array}{c c} 20 & 25 \\ \hline 62 & 75 \end{array}$

Notes:

a. See SOA curve for voltage derating.

b. Surface Mounted on 1" x 1" FR-4 boad.

<b>SPECIFICATIONS</b> $T_J = 25$	°C, unless	otherwise noted					
Parameter	Symbol	Test Conditions	Min	Typ <sup>a</sup>	Max	Unit	
Static		· · · ·			•		
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_D = -250 \mu A$	- 60			v	
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 1.0	- 2.0	- 3.0	v	
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
		$V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS}$ = - 60 V, $V_{GS}$ = 0 V, $T_{J}$ = 125 °C			- 50	μΑ	
		$V_{DS}$ = - 60 V, $V_{GS}$ = 0 V, $T_{J}$ = 175 °C			- 150		
On-State Drain Current <sup>b</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> = - 5 V, V <sub>GS</sub> = - 10 V	- 10			А	
		V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 5 A		0.061		Ω	
	r	$V_{GS}$ = - 10 V, I <sub>D</sub> = - 5 A, T <sub>J</sub> = 125 °C		0.100			
Drain-Source On-State Resistance <sup>b</sup>	r <sub>DS(on)</sub>	$V_{GS}$ = - 10 V, I <sub>D</sub> = - 5 A, T <sub>J</sub> = 175 °C		0.150			
		V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 2 A		0.072			
Forward Transconductance <sup>b</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 5 A		8		S	
Dynamic	•	•		÷	•		
Input Capacitance	C <sub>iss</sub>			1000			
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz		120		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			100		1	
Total Gate Charge	Qg			10			
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = - 30 V, $V_{GS}$ = - 10 V, $I_D$ = - 8.4 A		2.1		nC	
Gate-Drain Charge	Q <sub>gd</sub>			3.2		1	
Gate Resistance	Rg	f = 1 MHz		8.0		Ω	
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>			6			
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD}$ = - 30 V, $R_L$ = 3.57 $\Omega$		15		ns	
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	$I_{D} \cong$ - 8.4 A, $V_{GEN}$ = - 10 V, $R_{G}$ = 2.5 $\Omega$				115	
Fall Time <sup>c</sup>	t <sub>f</sub>			8			
Source-Drain Diode Ratings and Cha	aracteristics	(T <sub>C</sub> = 25 °C) <sup>b</sup>					
Pulsed Current	I <sub>SM</sub>				- 30	А	
Forward Voltage <sup>b</sup>	V <sub>SD</sub>	I <sub>F</sub> = - 2 A, V <sub>GS</sub> = 0 V		- 0.9	- 1.3	V	
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = - 8 A, di/dt = 100 A/μs		50		ns	
Reverse Recovery Time	Q <sub>rr</sub>	$r_{\rm F} = -0.7$ , $u/u_{\rm C} = 100.7/\mu_{\rm S}$		80		nC	

Notes:

a. Guaranteed by design, not subject to production testing.

b. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

c. Independent of operating temperature.

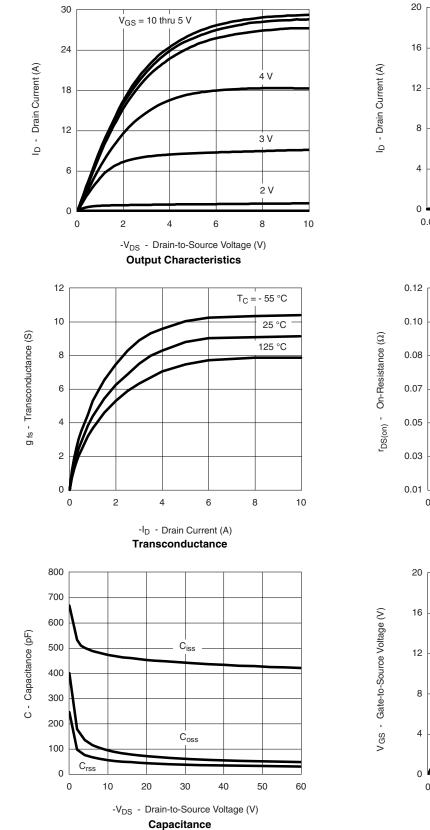
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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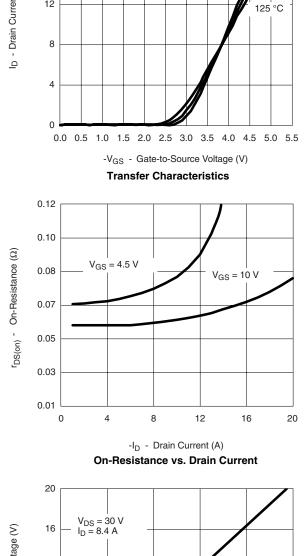


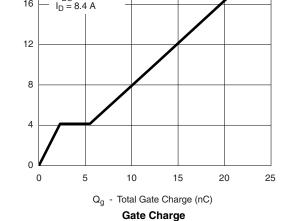
T<sub>C</sub> = - 55 °C

1 25 °C



#### TYPICAL CHARACTERISTICS 25 °C unless noted

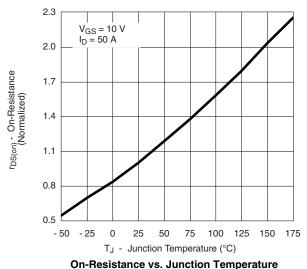


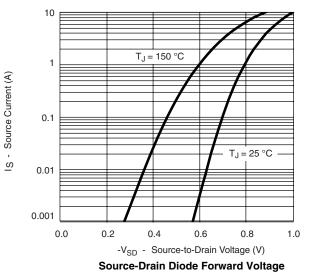


服务热线:400-655-8788

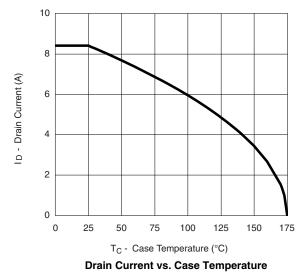


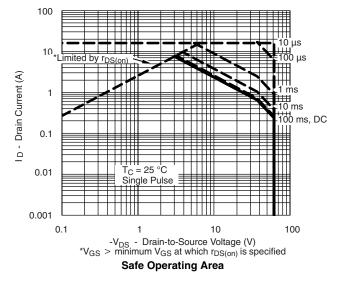
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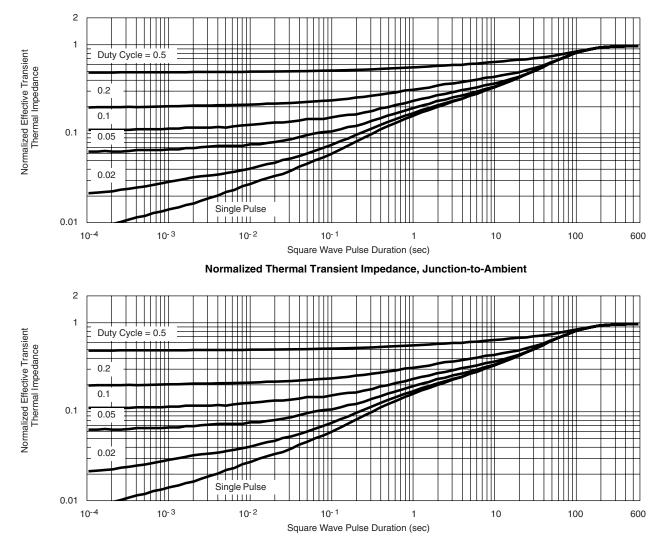
#### THERMAL RATINGS







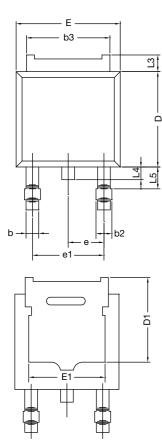
#### THERMAL RATINGS



Normalized Thermal Transient Impedance, Junction-to-Case



## **TO-252AA CASE OUTLINE**





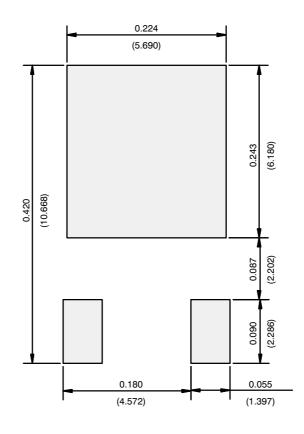
	MILLIN	<b>IETERS</b>	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	2.18	2.38	0.086	0.094
A1	-	0.127	-	0.005
b	0.64	0.88	0.025	0.035
b2	0.76	1.14	0.030	0.045
b3	4.95	5.46	0.195	0.215
С	0.46	0.61	0.018	0.024
C2	0.46	0.89	0.018	0.035
D	5.97	6.22	0.235	0.245
D1	5.21	-	0.205	-
E	6.35	6.73	0.250	0.265
E1	4.32	-	0.170	-
Н	9.40	10.41	0.370	0.410
е	2.28 BSC		0.090 BSC	
e1	4.56	BSC	0.180 BSC	
L	1.40	1.78	0.055	0.070
L3	0.89	1.27	0.035	0.050
L4	-	1.02	-	0.040
L5	1.14	1.52	0.045	0.060
ECN: X12-( DWG: 5347	0247-Rev. M,	24-Dec-12		

Note

• Dimension L3 is for reference only.



### **RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)**



Recommended Minimum Pads Dimensions in Inches/(mm)



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